

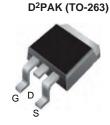
Power MOSFET

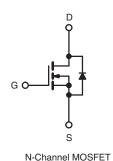
PRODUCT SUMMARY					
V _{DS} (V)	600				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.6			
Q _g (Max.) (nC)	200				
Q _{gs} (nC)	2	4			
Q _{gd} (nC)	11	10			
Configuration	Sin	gle			

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted) PARAMETER SYMBOL UNIT LIMIT 600 Drain-Source Voltage VDS V Gate-Source Voltage V_{GS} ± 20 12 T_C = 25 °C V_{GS} at 10 V Continuous Drain Current I_{D} $T_C = 100 \degree C$ 9 А Pulsed Drain Currenta 36 I_{DM} W/°C Linear Derating Factor 1.5 Single Pulse Avalanche Energy^b E_{AS} 880 mJ Repetitive Avalanche Current^a I_{AR} 8.7 А Repetitive Avalanche Energy^a 19 mJ E_{AR} Maximum Power Dissipation $T_C = 25 \ ^{\circ}C$ P_D 190 W Peak Diode Recovery dV/dtc dV/dt 1.5 V/ns Operating Junction and Storage Temperature Range - 55 to + 150 T_J, T_{stg} °C Soldering Recommendations (Peak Temperature) for 10 s 300^d 10 lbf · in 6-32 or M3 screw Mounting Torque 1.1 N·m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 37 mH, $R_g = 25 \Omega$, $I_{AS} = 6.7$ A (see fig. 12). c. $I_{SD} \le 6.7$ A, dl/dt ≤ 130 A/µs, $V_{DD} \le 600$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



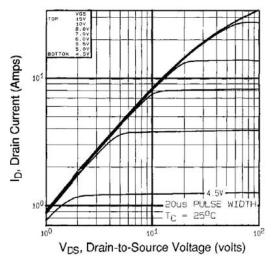
THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.65		

SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted)					
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							•
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V, I _D = 250 μA	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	1.2	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	_{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 6$	$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	100	
		V _{DS} = 560 V, V	′ _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	$I_D = 4.0 \text{ A}^{b}$	-	0.6	-	Ω
Forward Transconductance	g _{fs}	V _{DS} = 10	00 V, I _D = 4.0 A ^b	4.9	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	2900	-	
Output Capacitance	C _{oss}			-	270	-	pF
Reverse Transfer Capacitance	C _{rss}			-	92	-	
Total Gate Charge	Qg			-	-	200	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	I _D = 6.7 A, V _{DS} = 360 V, see fig. 6 and 13 ^b	-	-	24	nC
Gate-Drain Charge	Q _{gd}			-	-	110	1
Turn-On Delay Time	t _{d(on)}	$\label{eq:V_DD} V_{DD} = 475 \; \text{V}, \; \text{I}_{D} = 6.7 \; \text{A} \; , \\ \text{R}_{G} = 6.2 \; \Omega, \; \text{R}_{D} = 67 \; \Omega, \; \text{see fig. 10}^{\text{b}}$		-	20	-	- ns
Rise Time	t _r			-	34	-	
Turn-Off Delay Time	t _{d(off)}			-	130	-	
Fall Time	t _f		-	37	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH
Internal Source Inductance	L _S			-	13	-	
Drain-Source Body Diode Characteristic	cs	•				•	
Continuous Source-Drain Diode Current	١ _S	MOSFET symbo showing the	MOSFET symbol		-	9	Α
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	18	
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 6.7 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C - 4	6.7 A dl/dt = 100 A lush	I	610	920	ns
Body Diode Reverse Recovery Charge	Q _{rr}	− T _J = 25 °C, I _F = 6.7 A, dl/dt = 100 A/μs ^b -		-	3.2	4.8	μC
Forward Turn-On Time	t _{on}	Intrinsic turn	-on time is negligible (turn	-on is doi	minated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics, T_C = 25 °C

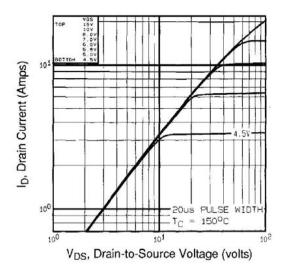
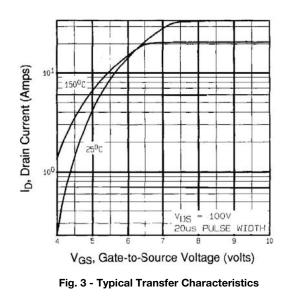


Fig. 2 - Typical Output Characteristics, T_C = 150 $^\circ C$



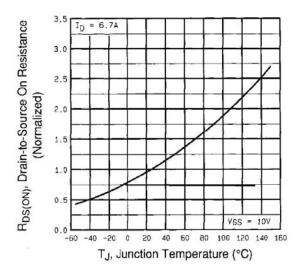


Fig. 4 - Normalized On-Resistance vs. Temperature



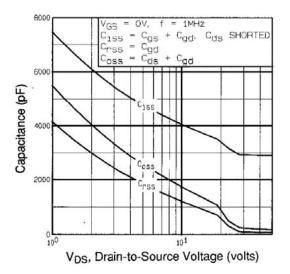


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

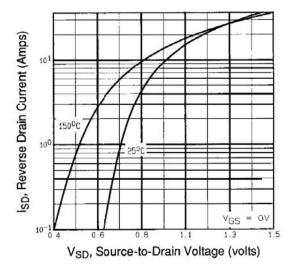


Fig. 7 - Typical Source-Drain Diode Forward Voltage

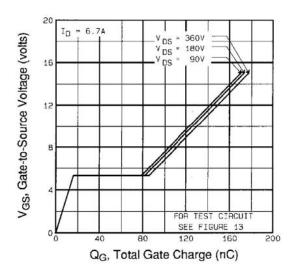


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

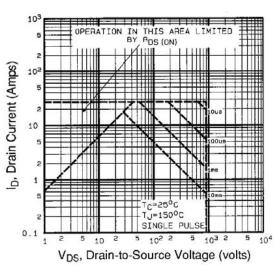


Fig. 8 - Maximum Safe Operating Area



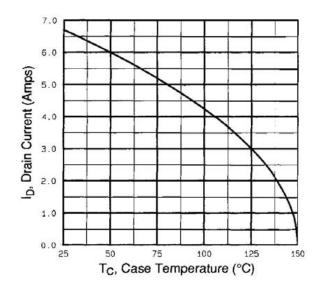


Fig. 9 - Maximum Drain Current vs. Case Temperature

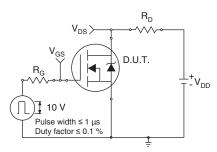


Fig. 10a - Switching Time Test Circuit

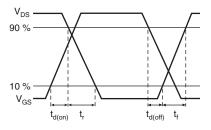


Fig. 10b - Switching Time Waveforms

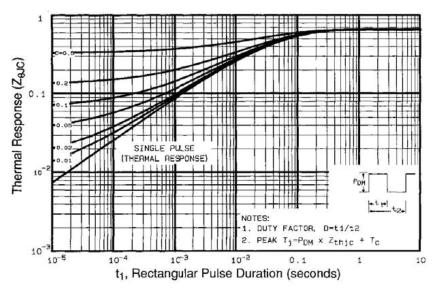


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



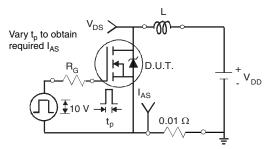


Fig. 12a - Unclamped Inductive Test Circuit

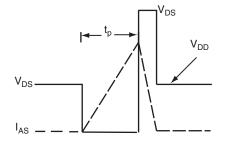


Fig. 12b - Unclamped Inductive Waveforms

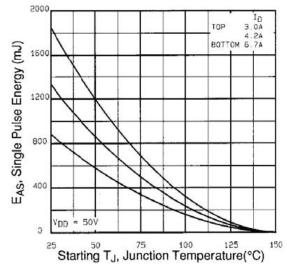


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

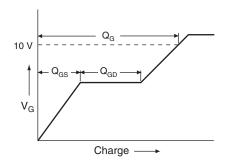
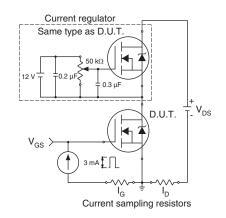


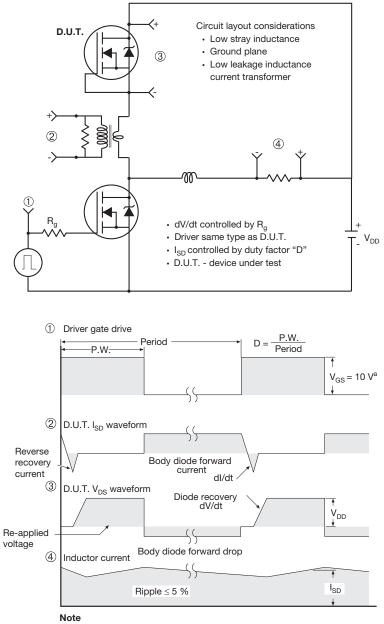
Fig. 13a - Basic Gate Charge Waveform







Peak Diode Recovery dV/dt Test Circuit

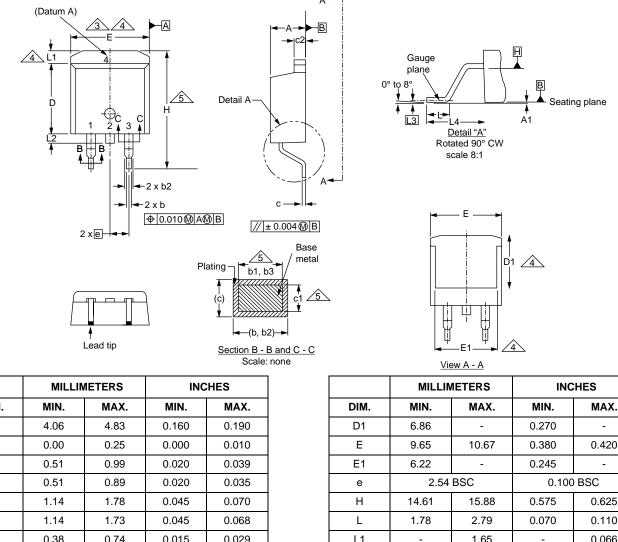


a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



TO-263AB (HIGH VOLTAGE)



DIM.	MILLIMETERS		INCHES			MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.	DIM.	MIN.	MAX.	MIN.	MA
А	4.06	4.83	0.160	0.190	D1	6.86	-	0.270	-
A1	0.00	0.25	0.000	0.010	E	9.65	10.67	0.380	0.42
b	0.51	0.99	0.020	0.039	E1	6.22	-	0.245	-
b1	0.51	0.89	0.020	0.035	е	2.54 BSC		0.100 BSC	
b2	1.14	1.78	0.045	0.070	Н	14.61	15.88	0.575	0.62
b3	1.14	1.73	0.045	0.068	L	1.78	2.79	0.070	0.11
С	0.38	0.74	0.015	0.029	L1	-	1.65	-	0.06
c1	0.38	0.58	0.015	0.023	L2	-	1.78	-	0.07
c2	1.14	1.65	0.045	0.065	L3	0.25 BSC		0.010 BSC	
D	8.38	9.65	0.330	0.380	L4	4.78	5.28	0.188	0.20

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

4. Thermal PAD contour optional within dimension E, L1, D1 and E1.

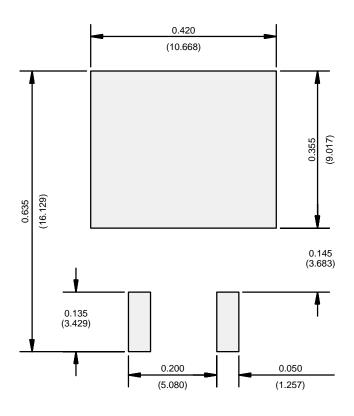
5. Dimension b1 and c1 apply to base metal only.

6. Datum A and B to be determined at datum plane H.

7. Outline conforms to JEDEC outline to TO-263AB.



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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